



LUCKI CM ELECTRONICS Co., Ltd

APPROVAL SHEET

Customer:	
Part Number:	3215 Seam Sealing Crystal
LK Part No.:	L318SK32ML
Holder :	SMD3215
Frequency:	32.768kHZ ±20*10 ⁻⁶ / 12.5PF

Prepared	Checked	Approved	
Zhao Qian	Zhang Dongwei	Zhang Bin	

2023-04-12

(For Customer Use)

Date:

Acceptable	

INTRODUCTION

- The contents is subject to change without notice.
 Please exchange the specification sheets regarding the product's warranty.
- 2. This sheet is not intended to guarantee or provide an approval of implementation of industrial patents.
- We have prepared this sheet as carefully as possible. If you find it incomplete or unsatisfactory in any respect, We would welcome your comments.

Contents

tem No. Item		Page	
[1]	Absolute maximum ratings	2	
[2]	Operating range	2	
[3]	Static characteristics	2	
[4]	Environmental and Mechanical characteristics	3 to 4	
[5] Dimensions and Marking layout		5 to 6	
[6]	Notes	7	

[1] Absolute maximum ratings

Item	Symbol	Rating value	
Storage temperature	Tstg	-55°C to+125°C	
Maximum drive level	DL	1.0 μW	

[2] Operating range

	Symbol	Value		
Item		Min.	Тур.	Max.
Operating temperature range	Topr	-40°C		+85°C
Drive level	DL	0.01 µW	0.1 μW	0.5 µW
Vibration mode			Fundamental	

[3] Static characteristics

Item	Symbol	Value	Note	
Frequency	fi	32.768 kHz		
Frequency tolerance	Δ f/f	± 20 ×10 ⁻⁶	CL = 12.5 pF Ta = +25±3°C, Drive level : 0.1 μW Not include aging	
Series resistance	Rı	70 k Ω Max.		
Motional capacitance	Cı	Typ. 3.4 fF	CI meter : Saunders 140B Drive level : 0.5 µW	
Shunt capacitance	Co	Typ. 1.2 pF		
Turnover temperature	θT	+25 ± 5 °C	Values are calculated by the frequencies +10, +25, +40°C with C-MOS circuit.	
Temperature coefficient	a	-4.0 × 10 ⁻⁸ /°C ² Max.		
Isolation resistance	IR	500 MΩ Min.	DC 100V, 60 seconds Between terminal #1 and terminal #2	
Aging	fa	$\pm 3 \times 10^{-6}$ / year	Ta = +25 °C ± 3 °C Drive level : 0.1 μW	

[4] Environmental and Mechanical characteristics

No.	Items	Value	Conditions		
1	Shock resistance	*3Δ f/f : ± 8 ×10 ⁻⁶	100g dummy(SEIKO EPSON Standard), Natura 500 mm height on to the concrete. 3 directions × 10 times	al drop from	
2	Vibration resistance	*3\Delta f/f: \pm 3 \times 10^6	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s² 10 Hz → 500 Hz → 10 Hz 15 min./cycle 6 h (2 hours , 3 directions)	*2	
3	Soldering heat resistance	Δ f/f: ± 5 ×10 ⁻⁶	For convention reflow soldering furnace (2	times)	
4 High temperature storage		*3\Delta f/f: \pm 10 \times 10^6	+125 °C × 1000 h	*1	
		*3\Delta f/f: \pm 7 \times 10^6	+85°C× 1000 h	*1	
5	Low temperature storage	*3\Delta f/f: \pm 10 \times 10^6	-55 °C× 1000 h	*1	
6	High temperature and humidity	*3Δ f/f: ± 10 ×10 ⁻⁶	+85°C × 85%RH × 1000 h	*1	
7	Temperature cycle	*3Δ f/f: ± 10 ×10 ⁻⁶	-6 -55 °C↔+125°C 30 minutes at each temperature × 100 cycles		
8	Sealing	*3 1 × 10 * hPa • 1 / s Max.	For He leak detector		
9	Shear	No peeling-off at a soldered part	20 N press for 10 ± 1 s. Ref. IEC 60068-2-21		
10	Pull - off	No peeling-off at a soldered part	20 N press for 10 ± 1 s. Ref. IEC 60068-2-21		
11	Substrate bending	No peeling-off at a soldered part	Bend width reaches 3 mm and hold for 5 s ± 1 s × 1 time Ref. IEC 60068-2-21		
12	Solvent resistance	The marking shall be legible	Ref. JIS C 0052 or IEC 60068-2-45		

< Notes >

Shift of series resistance at before and after the test should be less than ± 20 % or less than $\pm 15k\Omega$.

In case high temperature storage(± 125 °C \times 1 000 h), Soldering heat resistance, shift of series resistance at before and after the test should be less than ± 30 % or ± 20 k Ω .

^{1. *1} Each test done independently.

^{2. *2} Measuring 2 h to 24 h later leaving in room temperature after each test. Drive level: 0.5 μW

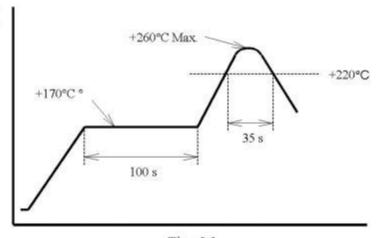
 ^{*3} Pre conditionings(Treat the Reflow 2 times with the following profile) Initial value shall be after 24 h
at room temperature.

• Air reflow

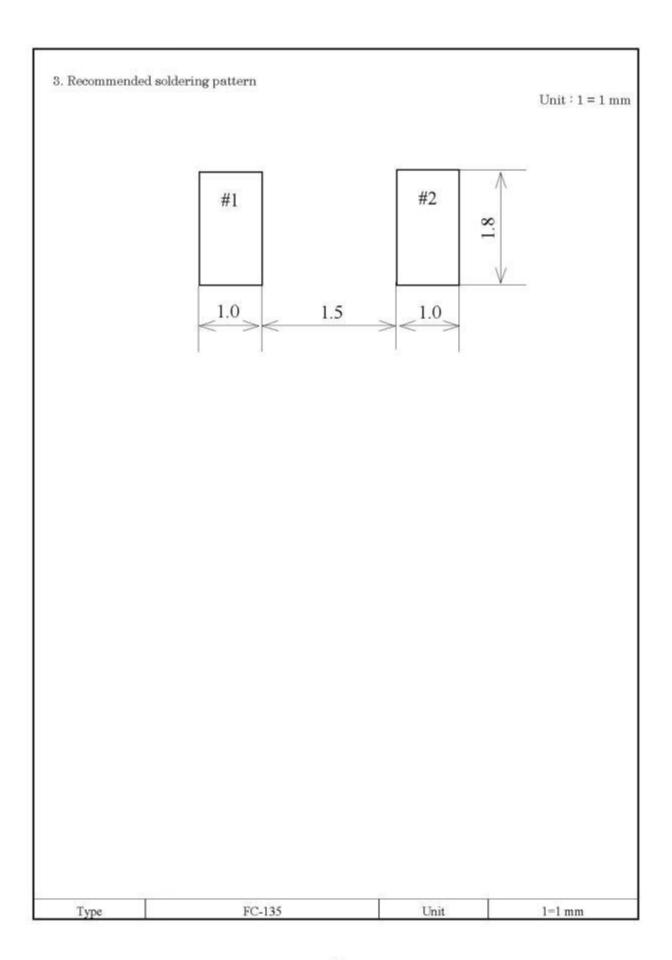
Pre heating temperature: +170 [°C] Heating temperature : +220 [°C]

Pre heating time: 100 [s] Heating time : 30 [s]

Temperature [°C]



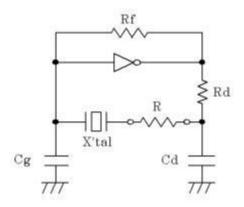
[5] Dimensions and Marking layout 1. Dimensions ±0.10 ±0.10 0.80 3.20 φ 0.55 (N.C) C0.2 #2 #1 0.1 ±0.10 < 0.65 → Package: Ceramic(Al₂O₃) Terminal Au plate: 0.5 µm Min. 2. Internal Connection Lid: Glass #2 #1 FC-135 Terminal treatment Au plating Unit 1 = 1 mmType



[6] Notes

- Max two (2) times reflow is allowed. Once miss soldering is happened, hand work soldering by soldering iron is recommended. (+350°C x within 5 s)
- 2. Patterning should be followed by our recommended one.
- 3. Applying excessive excitation force to the crystal resonator may cause deterioration damage.
- Unless adequate negative resistance is allocated in the oscillation circuit, start up time of oscillation may be increased, or no oscillation may occur.

How to check the negative resistance.



- Connect the resistance (R) to the circuit in series with the crystal resonator.
- (2) Adjust R so that oscillation can start (or stop).
- (3) Measure R when oscillation just start (or stop) in above (2).
- (4) Get the negative resistance

$$-R = R + CI$$
 value.

(5) Recommended -R

- The shortest patterning line on board is recommendable.Too long line on board may cause of abnormal oscillation.
- To avoid mull function, no pattern under or near the crystal is allowed.
 Solder paste should be more than 150 µm thickness.
- 7. This device must be stored at the normal temperature and humidity conditions before mounting on a board.
- Too much exciting shock or vibration may cause deterioration on damage.
 Depending on the condition such as a shock in assembly machinery, the products may be damaged.
 Please check your condition in advance to maintain shock level to be smallest.
- 9. Depending on the conditions, ultrasonic cleaning may cause resonant damage of the internal crystal resonator. Since we are unable to determine the conditions (type of cleaning unit, power, time, conditions inside the bath, etc.) to be used in your company, we cannot guarantee the safety of this unit when it is cleaned in an ultrasonic cleaner.
- 10. Ink marking may be damaged by some kind of solvent, please take precautions when choosing solvent by your selves.
- 11. Please refer to packing specification regarding how to storage the products in the pack.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Crystals category:

Click to view products by Lucki manufacturer:

Other Similar products are found below:

CX3225GB25000M0PPSZ1 718-13.2-1 7A-40.000MAAE-T FL2000085 99-BU 9B-15.360MBBK-B 9C-7.680MBBK-T H10S-12.000-18-EXT-TR ABC2-6.000MHZ-D4Z-T ABLS-20.000MHZ-D2-T ABS071-32.768KHZ-6-T R38-32.768-12.5-5PPM-NPB BTD1062E05A-513 21U15A-21.4MHZ RTX-781DF1-S-20.950 LFXTAL066198Cutt 9C-14.31818MBBK-T A-11.000MHZ-27 ABL-27.000MHZ-B4Y-T ABM11-132-24.000MHZ-T3 ABM3B1-25.000MHZ-D2Y-T SPT2A-.032768B SPT2A.032768G LFXTAL065253Cutt LFXTAL066431Cutt XT9S20ANA14M7456 XT9SNLANA16M 7A-24.576MBBK-T 7B-30.000MBBK-T CX2520DB16000H0HPQCC MMCC2R32.7680KHZ 6504-202-1501 6526-202-1501 ABLS-12.000MHZ-B2Y-T 7A-10.000MBBK-T SG636PCE-20.000MC 3404 CM315D32768EZFT C1E-24.000-7-2020-R C1E-19.200-12-1530-X-R C1E-16.000-12-1530-X-R ABM11-16.000MHZ-9-B1U-T FL5000014 EUCA18-3.1872M FX0800015 425F35E027M0000 FP0800018 MS3V-T1R-32.768kHz-7pF-20PPM-TA-QC-Au VXM7-1C1-16M000 MS3V-T1R-32.768kHz-9pF-20PPM-TA-QC-Au